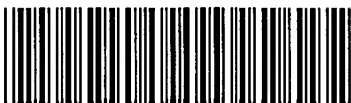


Search Notes

Application/Control No.

10/529,104

Examiner

Lam P. Pham

Applicant(s)/Patent under
Reexamination

KONNO, TAKESHI

Art Unit

2612

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 340 | 53. | 10/26/2006 | LP |
| | 5.31 | | |
| | 5.32 | | |
| | 5.33 | | |
| | 5.61 | | |
| | 5.62 | | |
| | 5.65 | | |
| | 5.72 | | |
| | 426.11 | | |
| 307 | 10.5 | 10/26/2006 | LP |
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| 455 | 63.1 | 10/26/2006 | LP |
| | 67.11 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|------------|------|
| EAST/BRS | 10/26/2006 | LP |
| CONSULT WITH BEN LEE, ED HOLLOWAY, JEFFERY HOFSSASS | 10/26/2006 | LP |
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